

Search Notes

Application/Control No.

09/837,862

Examiner

Tom Y. Lu

Applicant(s)/Patent under
Reexamination

DEKEL ET AL.

Art Unit

2621

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|-----------------------|-----------|----------|
| 382 | 240, 276- 277, 282 | 6/29/2005 | TYL |
| 375 | 240.19 | 6/29/2005 | TYL |
| 348 | 211.3 | 6/29/2005 | TYL |
| 709 | 203 | 6/29/2005 | TYL |
| 715 | 744 | 6/29/2005 | TYL |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-----------------------|----------|-----------|----------|
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| see printout attached | | 6/29/2005 | TYL |

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------------|-----------|------|
| EAST search printout attached | 6/29/2005 | TYL |
| IEEE search | 6/29/2005 | TYL |
| PALM name search | 6/29/2005 | TYL |
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